

Bulletin I0138J 01/00

FAST RECOVERY DIODES

■ Junction Size: Rectangular 207 x 157 mils

■ Wafer Size:

200 to 600 V ■ V_{RRM} Class:

Glassivated MOAT Passivation Process:

■ Reference IR Packaged Part: 20ETF Series

Major Ratings and Characteristics

Parameters		Units	Test Conditions	
V _{FM}	Maximum Forward Voltage	1300mV	$T_J = 25^{\circ}C, I_F = 20 A$	
V _{RRM}	Reverse Breakdown Voltage Range	200 to 600 V	$T_J = 25^{\circ}\text{C}, I_{RRM} = 100 \mu\text{A}$ (1))

⁽¹⁾ Nitrogen flow on die edge.

Mechanical Characteristics

Nominal Back Metal Composition, Thickness	Cr-Ni-Ag (1 KA-4 KA-6 KA)
Nominal Front Metal Composition, Thickness	100% AI, (20 μm)
Chip Dimensions	207 x 157 mils (5.26x3.99 mm) - see drawing
Wafer Diameter	100 mm, with std. < 110 > flat
WaferThickness	260 µm
Maximum Width of Sawing Line	45 µm
Reject Ink Dot Size	0.25 mm diameter minimum
Ink Dot Location	Seedrawing
Recommended Storage Environment	Storage in original container, in dessicated nitrogen, with no contamination

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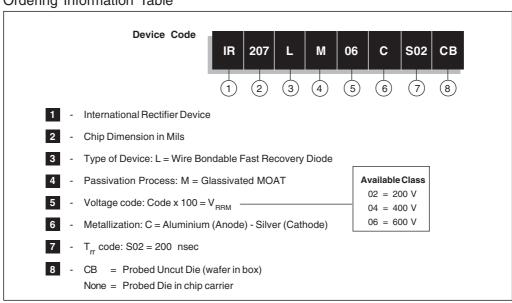
IR207LM..CS02CB Series

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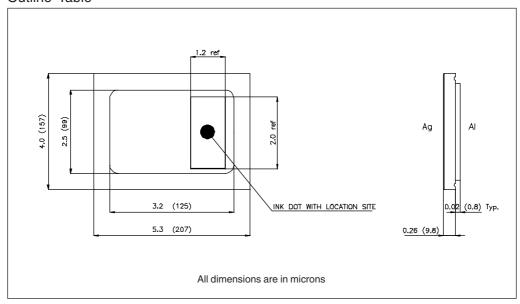
International

TOR Rectifier

Ordering Information Table



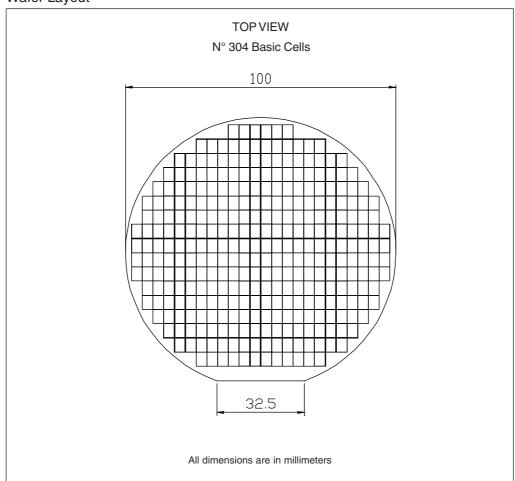
Outline Table



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Wafer Layout



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